

CERTITEK Standards Laboratory Co., Ltd.

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EMC TEST REPORT For FCC

Test Report No. : CTK03-F032

Date of Issue : April 17, 2003

Model/Type No: : B19AF

Kind of Product : LCD Monitor

Applicant : Hansol Electronics Inc.

Applicant Address : 27-29, Hanchon-Ri, Ducksan-Myun, Jinchon-Gun, Chungbuk,

365-840, Korea

Manufacturer : Hansol Electronics Inc.

Manufacturer Address : 27-29, Hanchon-Ri, Ducksan-Myun, Jinchon-Gun, Chungbuk,

365-840, Korea

Contact Person : Mr. S. P. Yang

Telephone : +82-43-530-8503

Received Date : March 26, 2003

Test period : Start: April 16, 2003 End: April 16, 2003

Test Results : X In Compliance Not in Compliance

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Joon Pak

EMC Test Engineer Date: April 17, 2003 Reviewed by

James Hong

EMC Technical Manager Date: April 17, 2003

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REPORT REVISION HISTORY

Date	Revision	Page No
April 17, 2003	(CTK03-F032) Issued	All

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1.0 General Product Description

1.0.1	Model Tests p	otherwise indicated, all tests were conducted on
1.0.2	Equipment 9	Size, Mobility and Identification
	Mobility:	380 by 176 by 368 \boxtimes mm \square in \square Hand-Held \boxtimes Table-top \square Floor-standing Not Applicable
1.0.3	Electrical Ra	atings
		90-240Vac, 50/60Hz, 0.65A Not applicable
1.0.4	Test Voltage	e & Frequency
		ed otherwise on the individual data sheet or test results, the test equency was as indicated below.
	Voltage: Frequency:	120V 60Hz
1.0.5	Clock & Oth	er Frequencies Utilized
	12MHz	

1.1 Model Differences

Not applicable

1.2 Device Modifications

The following modifications were necessary for compliance: Not applicable

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1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
PC	Samsung	M6050	812092ERB00347	DOC
PS/2 Mouse	PANWEST	Cyber Beetle	PM1F184045737	DOC
USB Mouse	PANWEST	Cyber Beetle	PM1F154000055	DOC
Serial Mouse	Microsoft	BASM1	4475951-20000	DOC
PS/2 Keyboard	San Hawk Teciing Co., Ltd	KB120	-	D840902 MIC
Earphone	-	HI-SONIC	=	=

#	Description	Ferrited	Length (m)	Other Details
1	PC Power Cable, Unshielded	No	1.8	Connect to AC Power
2	EUT Power Cable, Unshielded	No	1.8	Connect to AC Power
3	EUT Analog Cable, Shielded	Yes	1.8	Between EUT and PC
4	EUT DVI Cable, Shielded	Yes	1.8	Between EUT and PC
5	EUT Audio In Cable, Shielded	Yes	1.5	Between EUT and PC
6	PS/2 Mouse Cable, Shielded	No	1.8	Connect to PC
7	USB Mouse Cable, Shielded	No	1.8	Connect to PC
8	Serial Mouse Cable, Shielded	No	1.8	Connect to PC
9	PS/2 Keyboard Cable, Shielded	No	1.5	Connect to PC
10	Earphone Cable, Unshielded	No	3.0	Connect to EUT

n/a = not available

1.4 Test Software

☐ Pinging

	Name / Manufacturer / Version / TEMC Test / Compaq Computer / 1.	· ·
1.5	EUT Operating Mode(s) Equipment under test was operated d conditions:	uring the measurement under the following
	 ☐ Test program (H-Pattern) ☐ Standby ☐ Practice operation ☐ Resolution / Refresh Rate - 1280 	☐ Test program (color bar) ☐ Test program (customer specific) X 1024, 75Hz

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1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

1.8 Measurement Procedure

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

* Measurement procedures was In accordance with ANSI C63.4-1992 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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1.9 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	P -948, C-986
KOREA	MIC	10 meter Open Area Test Site and EMS (ESD, RS, EFT/Burst, Surge)	MIC No. 51, KR0025
International	KOLAS	EMC	KOLAS NO.119
Europe	GLAS	EMC EN 55011, EN 55022, EN 55024, EN 61326, EN 50130-4, EN 50081-1, EN 50081-2, EN 50082-1, EN 50082-2, EN 61000-6-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-4-11, EN 61000-3-2, EN 61000-3-3	TÜV No.13000796-02

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2.0 Emissions Test Regulations

the emissions tests were performed according	g to following regulations	5:
☐ EN 50081-1:1992		
☐ EN 55011:1998 +A1:1999	☐ Group 1 ☐ Class A	☐ Group 2 ☐ Class B
☐ EN 55013:1990 +A12:1994 +A13:1996 + ☐ EN 55013:2001	A14:1999	
☐ EN 55014-1:1993 +A1:1997 +A2:1999	☐ Household appliand ☐ Portable tools ☐ Semiconductor dev	
☐ EN 55014-1:2000 ☐ EN 55014-2:1997	Semiconductor dev	ices
☐ EN 55015:1996 +A1:1997 +A2:1999 ☐ EN 55015:2000		
☐ EN 55020:1994 +A11:1996 +A13:1999 + ☐ EN 55020:1994 +A11:1996 +A12:1999 +		
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 +A1:2000	☐ Class A ☐ Class A	☐ Class B☐ Class B
☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:2000 ☐ EN 61000-3-3:1995	+A14:2000	
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B
☐ FCC Part 15 SUBPART B	☐ Class A	⊠ Class B
☐ AS 3548 (1992)	☐ Class A	☐ Class B
□ CISPR 22 (1993) The unit was tested to CISPR 22 and complied FCC under paragraphs 15.107 and 15.109.	☐ Class A d with the alternate metl	☐ Class B nods allowed by

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Conducted Voltage Emissions 2.1

Test Date

April 16, 2003

Test Location EMI-CE: Shielded Roor	n		
Test Instruments ☑ Field Strength Mete	er Rohde & Schwarz	ESHS30	828144/002
Test Accessories ☐ LISN ☐ LISN ☐ LISN ☐ LISN ☐ Control PC	EMCO EMCO EMCO HP	3825/2 3825/2 3825/2 Vectra 500	9206-1971 9409-2246 9607-2574 SG72000192
Frequency Range (150 kHz to 30 MHz 450 kHz to 30 MHz			
Instrument Setting IF Band Width: 9 kHz	gs		
Test Results The requirements are:			
METNOT METNOT APPLICABLE	minimum margin is 9.5 dB limit exceeded by maximum		
Remarks			

See Appendix A for test data.

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2.2 Radiated Electric Field Emissions

Test Date April 16, 2003			
Test Location ☑ EMI-OATS: Testing was per ☐ EMI-OATS: Testing was per			
Test Instruments	Rohde & Schwarz	ESVS30	826638/008
Test Accessories ☐ ULTRA Broadband Antenna ☐ Biconical Antenna ☐ Biconical Antenna ☐ Log-periodic Antenna	Schwarzbeck EMCO	HL562 BBA9106 3110B 3146	361324/014 41-00201 9607-2564 9607-4567
Frequency Range of Mea 30 MHz to 1 GHz	surement		
Instrument Settings IF Band Width: 120 kHz			
Test Results The requirements are:			
	um margin is 3.4 dB (u xceeded by maximum o		

Remarks

See Appendix A for test data

■ NOT APPLICABLE

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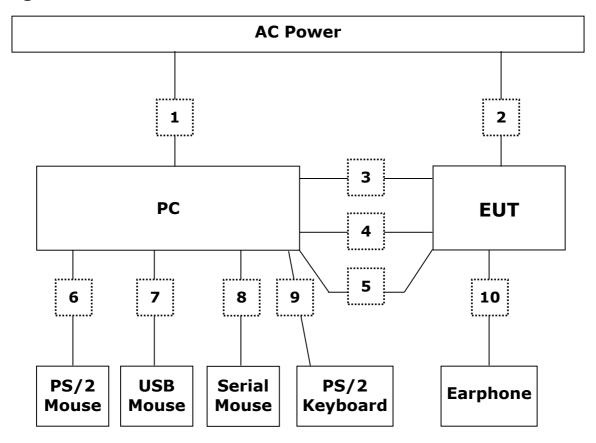
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Configuration







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APPENDIX A - TEST DATA

Conducted Voltage Emissions (Quasi-Peak reading)

Frequency	Corre	ection		Quasi-peak				Average			
,	Fac	tor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.15	2.2	0.1	L	66.0	48.3	50.6	15.4	56.0	9.1	11.4	44.6
0.15	2.2	0.1	N	66.0	48.9	51.2	14.8	56.0	11.0	13.3	42.7
0.18	2.2	0.1	N	64.7	42.8	45.1	19.7	54.7	5.2	7.5	47.2
0.18	1.7	0.1	L	64.5	44.2	46.0	18.5	54.5	13.9	15.7	38.8
0.19	1.7	0.1	L	64.0	43.4	45.2	18.9	54.0	5.9	7.7	46.3
0.21	1.7	0.1	N	63.4	50.2	52.0	11.4	53.4	40.5	42.3	11.1
0.21	1.7	0.1	L	63.4	47.4	49.2	14.2	53.4	31.4	33.2	20.2
24.08	0.5	0.4	L	60.0	40.8	41.7	18.3	50.0	39.7	40.6	9.5
24.49	0.5	0.4	L	60.0	41.3	42.2	17.8	50.0	26.6	27.5	22.5
24.59	0.5	0.4	N	60.0	38.9	39.8	20.2	50.0	30.9	31.8	18.3
24.80	0.5	0.4	N	60.0	39.6	40.5	19.5	50.0	30.8	31.7	18.3
24.90	0.5	0.4	L	60.0	40.8	41.7	18.3	50.0	31.3	32.2	17.8
25.10	0.5	0.4	N	60.0	40.1	41.0	19.0	50.0	31.0	31.9	18.1
25.20	0.5	0.4	N	60.0	39.5	40.4	19.6	50.0	31.0	31.9	18.2
25.20	0.5	0.4	L	60.0	41.1	42.0	18.0	50.0	33.9	34.8	15.2
25.62	0.5	0.4	N	60.0	40.2	41.1	18.9	50.0	30.7	31.6	18.4

Date: April 17, 2003

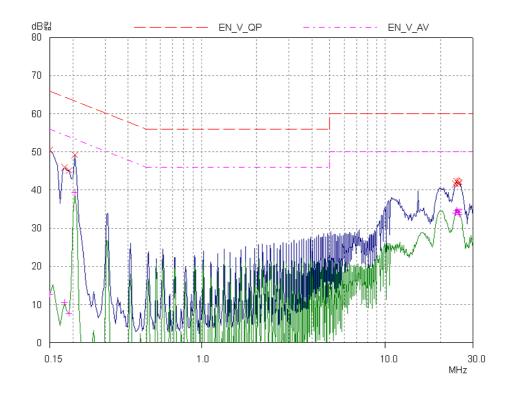
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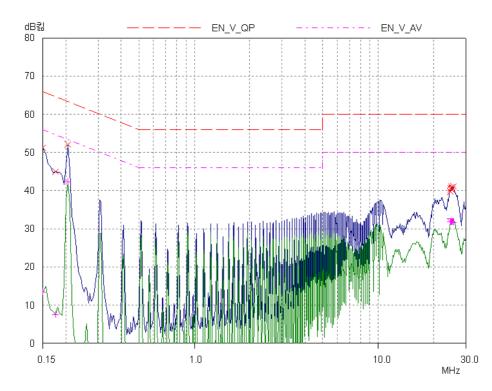
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Radiated Electric Field Emissions (Quasi-Peak reading)

Radiated	Liecti ic i	icia Li	111331011	s (Quas	i reak i	caumg <i>)</i>		
Frequency	Reading	Pol.	Height		Correction Factor		Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
42.27	11.6	V	1.0	12.8	1.3	30.0	25.7	4.3
70.54	18.3	V	1.0	6.7	1.6	30.0	26.6	3.4
114.46	12.8	V	1.0	9.5	2.0	30.0	24.3	5.7
132.65	14.9	Н	4.0	8.6	2.3	30.0	25.8	4.2
379.21	15.8	Н	1.2	13.1	3.9	37.0	32.8	4.2
398.06	14.2	Н	2.2	13.5	4.1	37.0	31.8	5.2
400.18	11.9	V	3.2	13.5	4.1	37.0	29.5	7.5
631.25	9.3	Н	1.0	17.4	5.3	37.0	32.0	5.0
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